



# **FQD1N80 / FQU1N80**

#### 800V N-Channel MOSFET

#### **General Description**

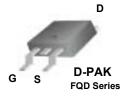
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

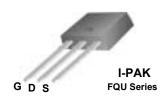
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

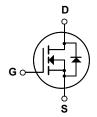
#### **Features**

- 1.0A, 800V,  $R_{DS(on)}$  = 20 $\Omega$  @V<sub>GS</sub> = 10 V Low gate charge ( typical 5.5nC)
- Low Crss (typical 2.7pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









## **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

| Symbol            | Parameter  |          | FQD1N80 / FQU1N80 | Units |
|-------------------|--|----------|-------------------|-------|
| V <sub>DSS</sub>  | Drain-Source Voltage   |          | 800               | V     |
| I <sub>D</sub>    | Drain Current - Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C) |          | 1.0               | Α     |
|                   |  |          | 0.63              | Α     |
| I <sub>DM</sub>   | Drain Current - Pulsed   | (Note 1) | 4.0               | Α     |
| $V_{GSS}$         | Gate-Source Voltage  |          | ± 30              | V     |
| E <sub>AS</sub>   | Single Pulsed Avalanche Energy   | (Note 2) | 90                | mJ    |
| I <sub>AR</sub>   | Avalanche Current  | (Note 1) | 1.0               | Α     |
| E <sub>AR</sub>   | Repetitive Avalanche Energy  | (Note 1) | 4.5               | mJ    |
| dv/dt             | Peak Diode Recovery dv/dt (Note 3)   |          | 4.0               | V/ns  |
| P <sub>D</sub>    | Power Dissipation (T <sub>A</sub> = 25°C) *  |          | 2.5               | W     |
|                   | Power Dissipation (T <sub>C</sub> = 25°C)  |          | 45                | W     |
|                   | - Derate above 25°C  |          | 0.36              | W/°C  |
| $T_J$ , $T_{STG}$ | Operating and Storage Temperature Range  |          | -55 to +150       | °C    |
| T <sub>L</sub>    | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds            |          | 300               | °C    |

#### **Thermal Characteristics**

| Symbol          | Parameter                                 | Тур | Max  | Units |
|-----------------|---|-----|------|-------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case      |     | 2.78 | °C/W  |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient * |     | 50   | °C/W  |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient   |     | 110  | °C/W  |

\* When mounted on the minimum pad size recommended (PCB Mount)

|   | Parameter   | Test Conditions  | Min          | Тур                                       | Max                             | Units                            |
|---|---|--|--------------|---|---------------------------------|----------------------------------|
| Off Cha   | aracteristics   |  |              |   |                                 |                                  |
| BV <sub>DSS</sub>   | Drain-Source Breakdown Voltage  | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA   | 800          |   |                                 | V                                |
| ΔBV <sub>DSS</sub><br>/ ΔT <sub>J</sub>   | Breakdown Voltage Temperature<br>Coefficient  | I <sub>D</sub> = 250 μA, Referenced to 25°C  |              | 1.0                                       |                                 | V/°C                             |
| I <sub>DSS</sub>  | Zero Gate Voltage Drain Current   | V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V   |              |   | 10                              | μΑ                               |
|   |   | V <sub>DS</sub> = 640 V, T <sub>C</sub> = 125°C  |              |   | 100                             | μΑ                               |
| I <sub>GSSF</sub>   | Gate-Body Leakage Current, Forward  | V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V  |              |   | 100                             | nA                               |
| I <sub>GSSR</sub>   | Gate-Body Leakage Current, Reverse  | V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V   |              | -   | -100                            | nA                               |
| On Cha  | aracteristics   |  | •            |   |                                 |                                  |
| V <sub>GS(th)</sub>   | Gate Threshold Voltage  | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$   | 3.0          |   | 5.0                             | V                                |
| R <sub>DS(on)</sub>   | Static Drain-Source<br>On-Resistance  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5 A   |              | 15.5                                      | 20                              | Ω                                |
| 9 <sub>FS</sub>   | Forward Transconductance  | V <sub>DS</sub> = 50 V, I <sub>D</sub> = 0.5 A   |              | 0.75                                      |                                 | S                                |
| C <sub>oss</sub><br>C <sub>rss</sub>  | Output Capacitance  Reverse Transfer Capacitance  | f = 1.0 MHz  |              | 20  | 26                              | pF                               |
| C <sub>rss</sub>  | Reverse Transfer Capacitance  | -  |              |   |                                 |                                  |
|   |   |  |              | 2.7                                       | 3.5                             | pF                               |
| Switch  | ing Characteristics   |  |              | 2.7                                       | 3.5                             | pF                               |
| Switchi   | ing Characteristics  Turn-On Delay Time   | Vop = 400 V lp = 1 0 A   |              | 10  | 3.5                             | pF                               |
| t <sub>d(on)</sub>  | T   | $V_{DD} = 400 \text{ V}, I_{D} = 1.0 \text{ A},$ $R_{C} = 25 \Omega$   |              |   | I                               |                                  |
| t <sub>d(on)</sub>  | Turn-On Delay Time  | $V_{DD} = 400 \text{ V}, I_{D} = 1.0 \text{ A},$ $R_{G} = 25 \Omega$   |              | 10  | 30                              | ns                               |
| t <sub>d(on)</sub>  | Turn-On Delay Time Turn-On Rise Time  |  |              | 10<br>25                                  | 30<br>60                        | ns<br>ns                         |
| $\begin{array}{c} t_{d(on)} \\ t_r \\ \\ t_{d(off)} \\ \end{array}$   | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time  |  |              | 10<br>25<br>15                            | 30<br>60<br>40                  | ns<br>ns                         |
| $\begin{array}{c} t_{d(on)} \\ t_r \\ \\ t_{d(off)} \\ \end{array}$   | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time   | $R_G = 25 \Omega$  |              | 10<br>25<br>15<br>25                      | 30<br>60<br>40<br>60            | ns<br>ns<br>ns                   |
| $\begin{array}{c} t_{d(on)} \\ t_r \\ \\ t_{d(off)} \\ \\ t_f \\ \\ Q_g \end{array}$  | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge   | $R_G = 25 \Omega$<br>$V_{DS} = 640 \text{ V}, I_D = 1.0 \text{ A},$  |              | 10<br>25<br>15<br>25<br>5.5               | 30<br>60<br>40<br>60<br>7.2     | ns<br>ns<br>ns<br>ns             |
| $\begin{array}{c} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$  | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge  | $R_G = 25 \Omega$<br>$V_{DS} = 640 \text{ V}, I_D = 1.0 \text{ A},$<br>$V_{GS} = 10 \text{ V}$   | <br><br><br> | 10<br>25<br>15<br>25<br>5.5<br>1.1        | 30<br>60<br>40<br>60<br>7.2     | ns<br>ns<br>ns<br>ns             |
| $\begin{array}{c} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$  | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge  | $R_G = 25 \Omega$<br>$V_{DS} = 640 \text{ V}, I_D = 1.0 \text{ A},$<br>$V_{GS} = 10 \text{ V}$<br>and Maximum Ratings                              | <br><br><br> | 10<br>25<br>15<br>25<br>5.5<br>1.1        | 30<br>60<br>40<br>60<br>7.2     | ns<br>ns<br>ns<br>ns             |
| $\begin{array}{c} t_{d(on)} \\ t_r \\ \end{array}$ $\begin{array}{c} t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$ $\begin{array}{c} \textbf{Drain-S} \\ I_S \\ \end{array}$ | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge  | $R_G = 25 \Omega$ $V_{DS} = 640 \text{ V}, I_D = 1.0 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Ratings and Forward Current                   | <br><br><br> | 10<br>25<br>15<br>25<br>5.5<br>1.1<br>3.3 | 30<br>60<br>40<br>60<br>7.2<br> | ns<br>ns<br>ns<br>ns<br>nC<br>nC |
| $egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$  | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge  Source Diode Characteristics ar Maximum Continuous Drain-Source Dio     | $R_G = 25 \Omega$ $V_{DS} = 640 \text{ V}, I_D = 1.0 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Ratings and Forward Current                   |              | 10<br>25<br>15<br>25<br>5.5<br>1.1<br>3.3 | 30<br>60<br>40<br>60<br>7.2<br> | ns<br>ns<br>ns<br>ns<br>nC<br>nC |
| $\begin{aligned} & t_{d(on)} \\ & t_r \\ & t_{d(off)} \\ & t_f \\ & Q_g \\ & Q_{gs} \\ & Q_{gd} \\ & \textbf{Drain-S} \\ & I_{SM} \end{aligned}$  | Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge  Source Diode Characteristics ar Maximum Continuous Drain-Source Diode F | $R_G = 25 \Omega$ $V_{DS} = 640 \text{ V}, I_D = 1.0 \text{ A},$ $V_{GS} = 10 \text{ V}$ And Maximum Ratings  and Forward Current  Forward Current | <br><br><br> | 10<br>25<br>15<br>25<br>5.5<br>1.1<br>3.3 | 30<br>60<br>40<br>60<br>7.2<br> | ns ns ns nc nC nC A              |

**Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 170mH, I<sub>AS</sub> = 1.0A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25 Ω, Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub>  $\leq$  1.0A, di/dt  $\leq$  200A/μs, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width  $\leq$  300μs, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

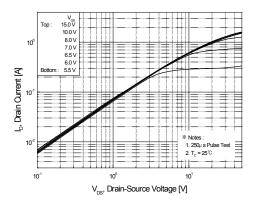


Figure 1. On-Region Characteristics

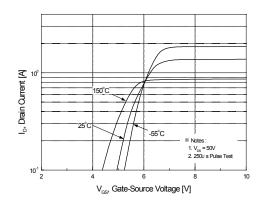


Figure 2. Transfer Characteristics

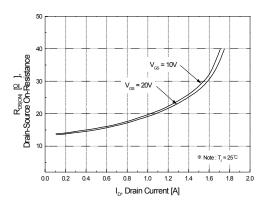


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

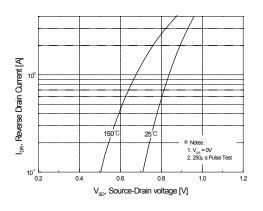


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

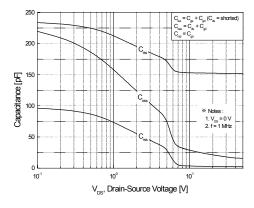


Figure 5. Capacitance Characteristics

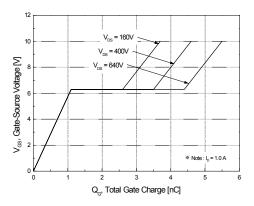


Figure 6. Gate Charge Characteristics

# Typical Characteristics (Continued)

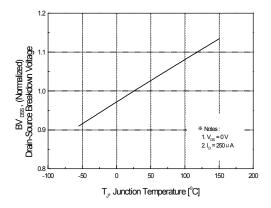
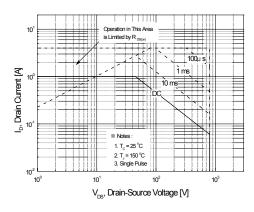


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



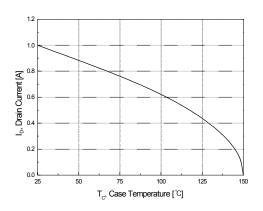


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

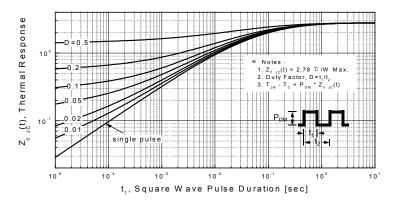
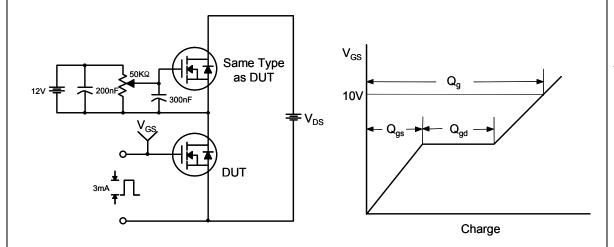


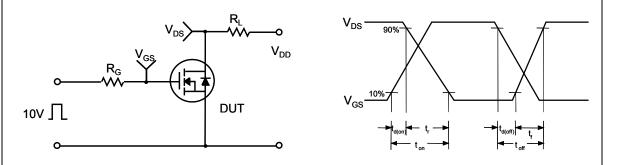
Figure 11. Transient Thermal Response Curve

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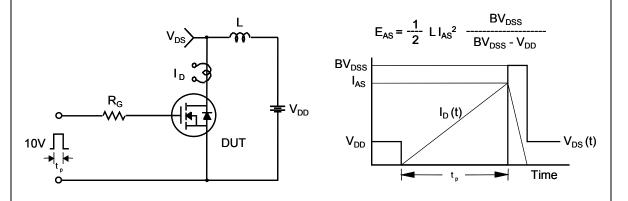
### **Gate Charge Test Circuit & Waveform**



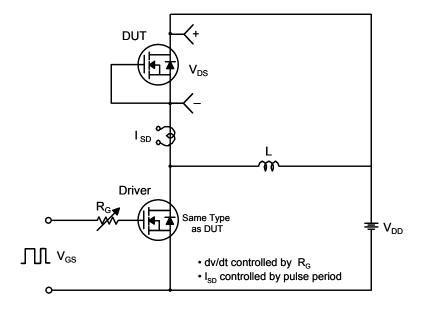
#### **Resistive Switching Test Circuit & Waveforms**

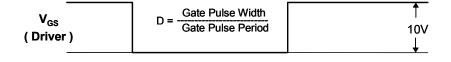


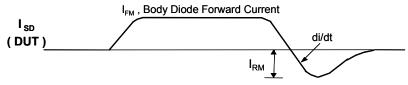
#### **Unclamped Inductive Switching Test Circuit & Waveforms**



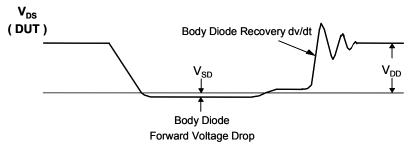
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms







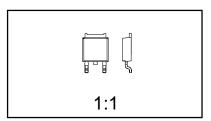
Body Diode Reverse Current



#### **Mechanical Dimensions**

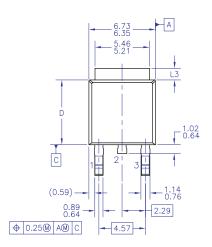
# TO-252 (DPAK) (FS PKG Code 36)

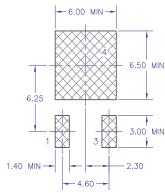




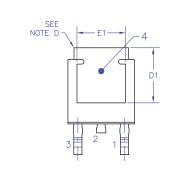
Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

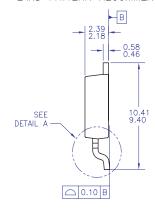
Part Weight per unit (gram): 0.33

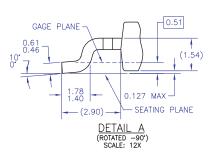




LAND PATTERN RECOMMENDATION







NOTES: UNLESS OTHERWISE SPECIFIED

A) ALL DIMENSIONS ARE IN MILLIMETERS.

B) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999.

C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.

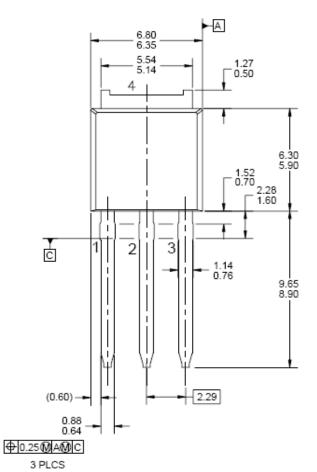
E) DIMENSIONS 13 DE18/D1 TABLE.

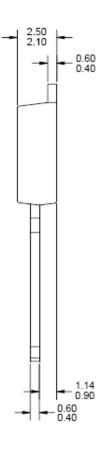
DIMENSIONS L3,D,E1&D1 TABLE:

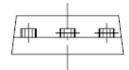
|    | OPTION AA | OPTION AB |
|----|-----------|-----------|
| L3 | 0.89-1.27 | 1.52-2.03 |
| D  | 5.97-6.22 | 5.33-5.59 |
| E1 | 4.32 MIN  | 3.81 MIN  |
| D1 | 5.21 MIN  | 4.57 MIN  |

### **Mechanical Dimensions**

# I - PAK







Dimensions in Millimeters





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